Application/Control No. 10/567,319	Applicant(s)/Pater Reexamination SNEH, OFER	nt Under
Examiner	Art Unit	
Rudy Zervigon	1792	Page 1 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,439,261 A	03-1984	Pavone et al.	156/345.47
*	В	US-5,788,799 A	08-1998	Steger et al.	156/345.37
*	O	US-5,997,588 A	12-1999	Goodwin et al.	29/25.01
*	D	US-6,111,225 A	08-2000	Ohkase et al.	219/390
*	Е	US-6,183,564 B1	02-2001	Reynolds et al.	118/719
*	F	US-6,308,932 B1	10-2001	Ettinger et al.	251/167
*	G	US-2001/0042514 A1	11-2001	Mizuno et al.	118/728
*	н	US-6,390,449 B1	05-2002	Ishigaki et al.	251/193
*	-	US-6,394,733 B1	05-2002	Toda et al.	414/221
*	7	US-6,409,837 B1	06-2002	Hillman, Joseph T.	118/712
*	К	US-2002/0144786 A1	10-2002	Chiang et al.	156/345.51
*	L	US-2002/0144657 A1	10-2002	Chiang et al.	118/723.00E
*	М	US-6,517,048 B2	02-2003	Ettinger et al.	251/167

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 04193946 A	07-1992	Japan	OGAWA et al.	
	0	WO 2005003406 A2	01-2005	World Intellect	SNEH, OFER	
	Р	WO 03062490 A2	07-2003	World Intellect	SNEH O	
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NON DATENT DOCUMENTS

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Examiner	Art Unit	
Rudy Zervigon	1792	Page 2 of 4

II S PATENT DOCUMENTS

	U.S. PAIENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,663,714 B2	12-2003	Mizuno et al.	118/719
*	В	US-2004/0083978 A1	05-2004	Welch et al.	118/733
*	С	US-2004/0149214 A1	08-2004	Hirose et al.	118/715
*	D	US-6,827,789 B2	12-2004	Lee et al.	118/719
*	Е	US-6,846,380 B2	01-2005	Dickinson et al.	156/345.31
*	F	US-2005/0051100 A1	03-2005	Chiang et al.	118/728
*	G	US-6,902,623 B2	06-2005	Gurary et al.	118/719
*	Н	US-2005/0160983 A1	07-2005	Sneh, Ofer	118/715
*	_	US-2005/0193948 A1	09-2005	Oohirabaru et al.	118/719
*	J	US-2005/0217578 A1	10-2005	Gurary et al.	118/715
*	к	US-7,018,504 B1	03-2006	Raaijmakers et al.	156/345.31
*	L	US-7,008,879 B2	03-2006	Lee et al.	438/758
*	М	US-2006/0150904 A1	07-2006	Ozaki et al.	118/715

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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Examiner	Art Unit		
Rudy Zervigon	1792	Page 3 of 4	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,138,336 B2	11-2006	Lee et al.	438/680
*	В	US-7,147,719 B2	12-2006	Welch et al.	118/715
*	C	US-2007/0051312 A1	03-2007	Sneh, Ofer	118/719
*	D	US-7,214,274 B2	05-2007	Wallace et al.	118/719
*	Е	US-7,247,207 B2	07-2007	Makino et al.	118/719
*	F	US-2007/0186857 A1	08-2007	Kim et al.	118/723.R
*	G	US-7,276,124 B2	10-2007	Gurary et al.	118/719
*	Н	US-2007/0269983 A1	11-2007	Sneh, Ofer	438/689
*	-	US-7,335,277 B2	02-2008	Makino et al.	156/345.32
*	7	US-7,416,633 B2	08-2008	Makino et al.	156/345.27
*	К	US-7,422,636 B2	09-2008	Ishizaka, Tadahiro	118/719
*	L	US-2009/0156015 A1	06-2009	Park et al.	438/758
*	М	US-2009/0176355 A1	07-2009	Okumura et al.	438/513

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

ı	Application/Control No. 10/567,319	Applicant(s)/Patent Under Reexamination SNEH, OFER		
	Examiner	Art Unit		
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II S PATENT DOCUMENTS

U.S. PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2009/0209095 A1	08-2009	Horii, Sadayoshi	438/585
*	В	US-7,585,383 B2	09-2009	Oohirabaru et al.	156/345.32
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS				
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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.